

ACKNOWLEDGMENT

The author expresses sincere gratitude to Dr. Vojin Vgoklobdzija, Dr. Sei-Ichi Watanabe, Yoshiyuki Kawana, Toshio Kato, Dr. Tsugio Makimoto, Ki-ichiro Mukai, Terushi Shimizu, Yasuhiro Ueda, Dr. Naohisa Ohta, Dr. Tadakuni Narabu and many fellow engineers in Sony who helped me to prepare this paper thru many fruitful discussions. They are my dear friends and mentors in private and public life.